DATA SHEET



NDL7408P Series

1 310 nm InGaAsP STRAINED MQW DC-PBH LASER DIODE COAXIAL MODULE WITH SINGLE MODE FIBER

DESCRIPTION

NDL7408P Series is a 1 310 nm laser diode coaxial module with single mode fiber. It has a strained Multiple Quantum Well (st-MQW) structure and a built-in InGaAs monitor photo diode. It is recommended for junction or access network systems. The series is available in two types of output power: 1.0 mW and 0.2 mW.

FEATURES

• Center wavelength $\lambda c = 1 310 \text{ nm}$

Two types of output power: 1.0 mW (NDL7408PK Series)

0.2 mW (NDL7408PL Series)

Low threshold current
 Ith = 12 mA TYP. @Tc = 25 °C

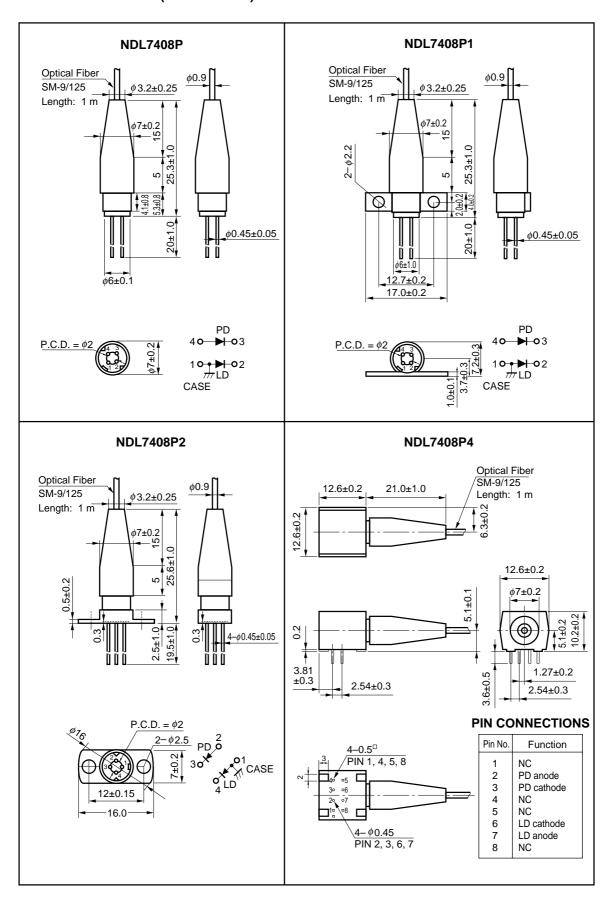
• High cut-off frequency fc = 2.0 GHz

• InGaAs monitor PIN-PD

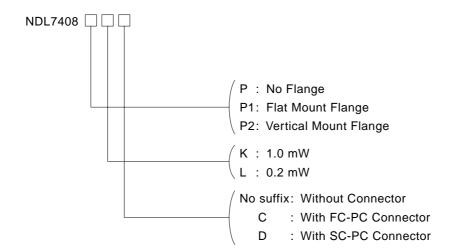
• Wide operating temperature range: -40 to +85 °C

• Based on Bellcore TA-NWT-000983

★ PACKAGE DIMENSIONS (in millimeters)



ORDERING INFORMATION



Part Number	Ranks	Description		
NDL7408PK	М	1.0 mW	Without Connector	
NDL7408PKC		No Flange	With FC-PC Connector	
NDL7408PKD			With SC-PC Connector	
NDL7408P1K	М	1.0 mW	Without Connector	
NDL7408P1KC		Flat Mount Flange	With FC-PC Connector	
NDL7408P1KD			With SC-PC Connector	
NDL7408P2K	М	1.0 mW	Without Connector	
NDL7408P2KC		Vertical Flange	With FC-PC Connector	
NDL7408P2KD			With SC-PC Connector	
NDL7408P4K	М	1.0 mW	Without Connector	
NDL7408P4KC		8-pin DIP	With FC-PC Connector	
NDL7408P4KD			With SC-PC Connector	
NDL7408PL	N	0.2 mW	Without Connector	
NDL7408PLC		No Flange With FC-PC Connector		
NDL7408PLD			With SC-PC Connector	
NDL7408P1L	N	0.2 mW	Without Connector	
NDL7408P1LC		Flat Mount Flange With FC-PC Connector		
NDL7408P1LD			With SC-PC Connector	
NDL7408P2L	N	0.2 mW	Without Connector	
NDL7408P2LC		Vertical Flange With FC-PC Connector		
NDL7408P2LD			With SC-PC Connector	
NDL7408P4L	N	0.2 mW Without Connector		
NDL7408P4LC		8-pin DIP With FC-PC Connector		
NDL7408P4LD			With SC-PC Connector	

ABSOLUTE MAXIMUM RATINGS (Tc = 25 °C, unless otherwise specified)

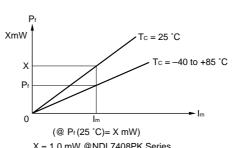
Parameter	Symbol	Ratings	Unit
Forward Current of LD	lF	Ith + 50	mA
Reverse Voltage of LD	VR	2.0	V
Forward Current of PD	lF	10	mA
Reverse Voltage of PD	VR	20	V
Operating Case Temperature	Tc	-40 to +85	°C
Storage Temperature	T _{stg}	-40 to +85	°C
Lead Soldering Temperature (10 s)	Tsld	260	°C

ELECTRO-OPTICAL CHARACTERISTICS (Tc = 25 °C, unless otherwise specified)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Operating Voltage	Vop	*1		1.1	1.3	٧
Threshold Current	Ith			10	25	mA
		Tc = +85 °C		25	50	
Modulation Current	Imod	P _f = 1.0 mW @NDL7408PK Series		15	30	mA
		Pf = 0.2 mW @NDL7408PL Series				
Differential Efficiency from Fiber	η d		0.025	0.050		W/A
for NDL7408PK Series		Tc = +85 °C	0.018	0.035		
Differential Efficiency from Fiber	$\eta_{ extsf{d}}$		0.010	0.015		
for NDL7408PL Series		Tc = +85 °C	0.005	0.010		
Center Emission Wavelength	λο	*1, RMS (-20 dB)	1 290	1 310	1 330	nm
		Tc = -40 to +85 °C	1 260		1 360	
Temperature Dependence of Center Emission Wavelength	Δλ/ΔΤ	Tc = -40 to +85 °C		0.4	0.5	nm/°C
Spectral Width	σ	*1, RMS (-20 dB)		1.3	2.5	nm
		Tc = +85 °C		1.5	4	
Cut-off Frequency	fc	-3 dB		2.0		GHz
Rise Time	tr	10 to 90 %		0.2	0.5	ns
Fall Time	tr	90 to 10 %		0.3	0.5	ns
Monitor Current of PD	Im	VRD = 5 V, *1	100	700		μΑ
Dark Current of PD	ΙD	VRD = 5 V		0.1	10	nA
Tracking Error	γ*2	I _m = const., T _c = -40 to +85 °C		0.5	1.0	dB

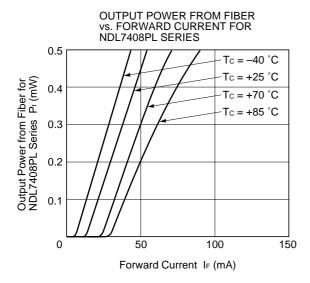
*1 Pf = 1.0 mW @NDL7408PK Series Pf = 0.2 mW @NDL7408PL Series

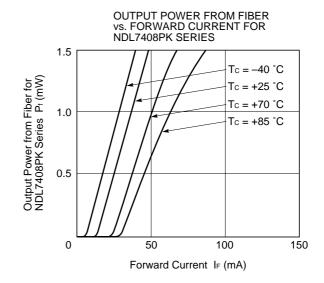
*2
$$\gamma = 10 \log \frac{P_f}{XmW}$$

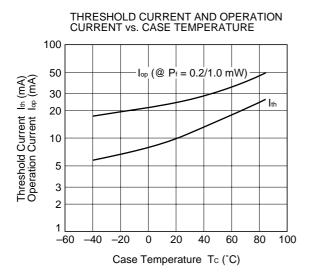


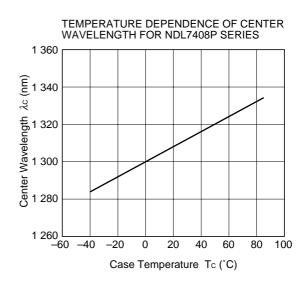
X = 1.0 mW @NDL7408PK Series X = 0.2 mW @NDL7408PL Series

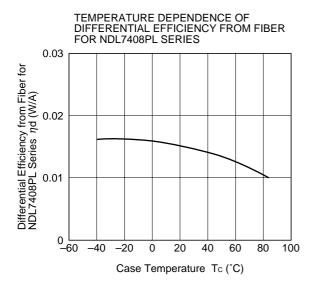
TYPICAL CHARACTERISTICS (Tc = -40 to +85 °C)

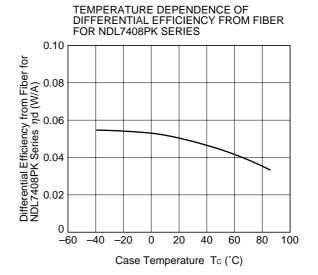




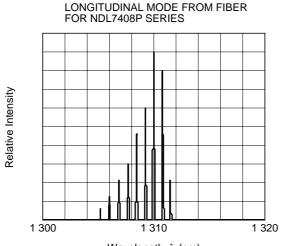




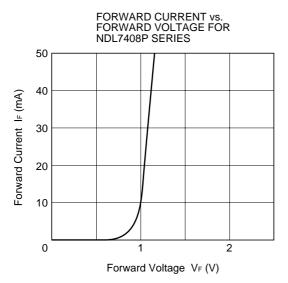


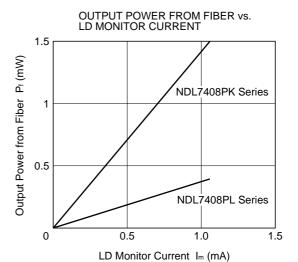


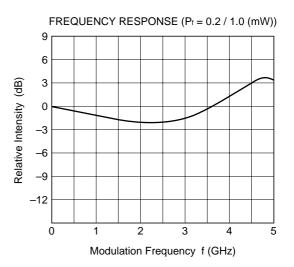
TYPICAL CHARACTERISTICS (Tc = 25 °C)













1.3 μm FABRY-PEROT DC-PBH LASER DIODE FAMILY

Features Package	Part Number	Remarks
φ5.6 mm Small Can	NDL7001	With monitor photo diode
φ5.6 mm Small Can with Lens	NDL7001L	With monitor photo diode
4-pin Coaxial Module with SMF	NDL7401P Series NDL7408P Series	Without TEC With monitor photo diode

REFERENCE

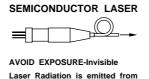
Document Name	Document No.
NEC semiconductor device reliability/quality control system	LEI-1201
Quality grades on NEC semiconductor devices	IEI-1209
Semiconductor device mounting technology manual	C10535E
Guide to quality assurance for semiconductor devices	MEI-1202
Semiconductor selection guide	X10679E

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CAUTION

Within this device there exists GaAs (Gallium Arsenide) material which is a harmful substance if ingested. Please do not under any circumstances break the hermetic seal.





this aperture

NEC Corporation
NEC Building, 7-1, Shiba 5-chome,
Minato-ku, Tokyo 108-01, Japan
Type number:
Manufactured:
Serial number:
This product conforms to FDA
regulations as applicable
to standards 21 CFR Chapter 1,
Subchapter J.

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Standard: Computers, office equipment, communications equipment, test and measurement equipment, audio and visual equipment, home electronic appliances, machine tools, personal electronic equipment and industrial robots

Special: Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support)

Specific: Aircrafts, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems or medical equipment for life support, etc.

The quality grade of NEC devices in "Standard" unless otherwise specified in NEC's Data Sheets or Data Books. If customers intend to use NEC devices for applications other than those specified for Standard quality grade, they should contact NEC Sales Representative in advance.

Anti-radioactive design is not implemented in this product.